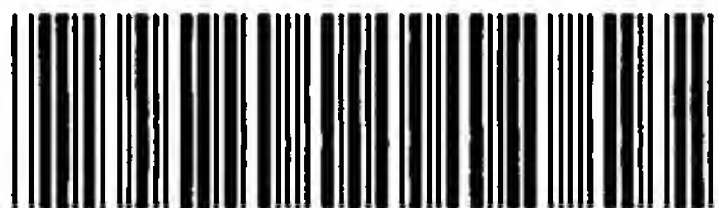


Search Notes**Application/Control No.**

10/549,630

Examiner

Jennifer Y. Cho

**Applicant(s)/Patent under
Reexamination**

ITOH ET AL.

Art Unit

1621

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Search	6/21/2007	JC
Inventor Search	6/21/2007	JC
East Search	6/21/2007	JC